

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10791046	DREGE ET AL.
	Examiner	Art Unit
	Hirl, Joseph P	2129

SEARCHED

Class	Subclass	Date	Examiner
706	12, 14, 46, @ad<20040301	9/25/7	JPH
700	110, @ad < 2004 03 01	9/25/7	JPH

SEARCH NOTES

Search Notes	Date	Examiner
East: all data bases, profile, model, parameter, training, machine, diffraction, signal, optimized, termination, @ad<20040301	9/25/7	JPH
IEEE: profile, model, learning machine, diffraction, @ad<20040301	9/25/7	JPH
Inventors: Drege, Doddi, Bao		

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner